Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,320	LEE, JEN-FENG	
Examiner	Art Unit	
Kim R. Lockett	2837	

	SEAR	CHED	
Class	Subclass	Date	Examiner
84	173-179		
	183		
	453		
372	333		
	321		
	328		
292	diszx	3/3/05	w

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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